

<b>Notice of References Cited</b>	Application/Control No. 10/587,890	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner SUNIL CHACKO	Art Unit 4146	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,307,640	10-2001	Motegi, Akihiko	358/1.14
*	C	US-4,843,571	06-1989	Notermans et al.	358/1.18
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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